

TSMC-01-1542



January 22, 2004

To: Commissioner for Patents  
P.O.Box 1450  
Alexandria, VA 22313-1450

Fr: George O. Saile, Reg. No. 19,572  
28 Davis Avenue  
Poughkeepsie, N.Y. 12603

Subject: | Serial No. 10/700,851 11/04/03 |

Andrew C.P. Lin

PERFORMANCE TUNING AT CM LOADER  
PROGRAM WHILE REPLICATING EQP LIST  
FOR IBM SiVIEW

#### INFORMATION DISCLOSURE STATEMENT

Enclosed is Form PTO-1449, Information Disclosure Citation  
In An Application.


The following Patents and/or Publications are submitted to  
comply with the duty of disclosure under CFR 1.97-1.99 and  
37 CFR 1.56.

#### CERTIFICATE OF MAILING

I hereby certify that this correspondence is being  
deposited with the United States Postal Service as first class  
mail in an envelope addressed to: Commissioner for Patents,  
P.O. Box 1450, Alexandria, VA 22313-1450, on January 27, 2004.

Stephen B. Ackerman, Reg.# 37761

Signature/Date

 1/27/04

U.S. Patent 6,345,259 to Sandoval, "System and Method for Integrating Business and Manufacturing Environments," discusses a system and method for the integrating of business manufacturing environments.

U.S. Patent 5,880,960 to Lin et al., "Method to Improve WIP Balance in a Manufacturing Line," discusses a method to improve WIP balance in a manufacturing line.

U.S. Patent 5,612,886 to Weng, "Method and System for Dynamic Dispatching in Semiconductor Manufacturing Plants," discusses a method and system for dynamic dispatching.

U.S. Patent 5,463,555 to Ward et al., "System and Method for Integrating a Business Environment with a Process Control Environment," discusses a system and method for integrating a business environment with a process control environment.

Sincerely,

A handwritten signature in black ink, appearing to read 'S. B. Ackerman', written over a horizontal line.

Stephen B. Ackerman,  
Reg. No. 37761

Application Number

10/700, 851

Andrew C.P. Lin

11/04/03

Group Art Unit

O I P E INFO  
 JAN 29 2004  
 PATENT TO THE PUBLIC OFFICE

(Use several sheets if necessary)

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## FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (Including Author, Title, Date, Portion or Pages, Etc.)

[illegible]

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.